

Notice of References Cited

Application/Control No.

09/732,769

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

Andrew Schechter

Art Unit

2871

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,334,993	08-1994	Okajima et al.	345/102
	B	US-5,422,751	06-1995	Lewis et al.	349/59
	C	US-6,295,103	09-2001	Yamatani et al.	349/58
	D	US-5,946,061	08-1999	Kurihara et al.	349/58
	E	US-5,986,726	11-1999	Murai, Tetsuya	349/59
	F	US-6,411,501	06-2002	Cho et al.	361/681
	G	US-6,292,239	09-2001	Nagamura et al.	349/58
	H	US-6,195,148	02-2001	Sasuga et al.	349/149
	I	US-5,570,267	10-1996	Ma, Hsi-Kuang	361/681
	J	US-6,480,245	11-2002	Sakamoto et al.	349/59
	K	US-6,452,649	09-2002	Ono et al.	349/61
	L	US-6,392,723	05-2002	Sugiyama et al.	349/58
	M	US			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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Andrew Schechter 1/11/03